



Day : Wednesday

Date: 7/16/2003 Time: 09:16:35

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Inventor Name Search Result

Your Search was:

Last Name = BEATY First Name = ELWIN

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>09844626</u>	Not Issued	071	04/27/2001	METHOD AND APPARATUS FOR THREE DIMENSIONAL INSPECTION OF ELECTRONIC COMPONENTS	BEATY, ELWIN M.
09844232	Not Issued	030	04/27/2001	METHOD AND APPARATUS FOR THREE DIMENSIONAL INSPECTION OF ELECTRONIC COMPONENTS	BEATY, ELWIN M.
09351892	Not Issued	071	07/13/1999	METHOD AND APPARATUS FOR THREE DIMENSIONAL INSPECTION OF ELECTRONIC COMPONENTS	BEATY, ELWIN M.
09321838	6064756	150	05/28/1999	APPARATUS FOR THREE DIMENSIONAL INSPECTION OF ELECTRONIC COMPONENTS	BEATY, ELWIN M.
<u>09321805</u>	6064757	150	05/28/1999	PROCESS FOR THREE DIMENSIONAL INSPECTION OF ELECTRONIC COMPONENTS	BEATY, ELWIN M.
09008243	6072898	150	01/16/1998	METHOD AND APPARATUS FOR THREE DIMENSIONAL INSPECTION OF ELECTRONIC COMPONENTS	BEATY, ELWIN M.
08955198	5909285	150	10/21/1997	THREE DIMENSIONAL INSPECTION SYSTEM	BEATY, ELWIN M.
08850473	6055054			THREE DIMENSIONAL INSPECTION SYSTEM	BEATY, ELWIN M.
08394642	5574668	150	02/22/1995	APPARATUS AND METHOD FOR MEASURING BALL GRID ARRAYS	BEATY, ELWIN M.
07945526	<u>5276546</u>	150	09/16/1992	THREE DIMENSIONAL SCANNING SYSTEM	BEATY, ELWIN M.
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07929939	5307149	250	METHOD AND APPARATUS FOR ZERO FORCE PART PLACEMENT	BEATY, ELWIN M.
07703285	5173796	150	THREE DIMENSIONAL SCANNING SYSTEM	BEATY, ELWIN M.
07408370	Not Issued	161	RETICLE FOR INTEGRATED CIRCUIT INSPECTION SYSTEM	BEATY, ELWIN M.

Inventor Search Completed: No Records to Display.

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